

**Search Notes****Application/Control No.**

10/549,615

**Examiner**

Linh V. Nguyen

**Applicant(s)/Patent under Reexamination**

HOSHINO ET AL.

**Art Unit**

2819

**SEARCHED**

Class	Subclass	Date	Examiner
375	340,341 335,265 207,267	6/21/2006	LN
370	252,335	6/21/2006	LN
370	270,331	6/21/2006	LN
714	702,755	6/21/2006	LN
341	50	6/21/2006	LN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East searched-see printout	6/21/2006	LN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner